

Search Notes

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Examiner

Eric B. Chen

Applicant(s)/Patent under
Reexamination

CHANG ET AL.

Art Unit

1765

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Inventor search (PALM)	1/5/2006	EC
EAST (all databases) (text search only)	1/5/2006	EC
252/79.1-79.4; 134/2,3; 438/745,754 216/105,106 (text search only) (consulted B. Tran, AU 1765)	1/5/2006	EC